Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/572,710	ZHU ET AL.
Examiner	Art Unit

Christian A. Hannon

2618

SEARCHED					
Class	Subclass	Date	Examiner		
455	566	8/31/2007	СН		
455	575.1	8/31/2007	СН		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted w/ E. Urban; See printout	8/31/2007	СН		
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